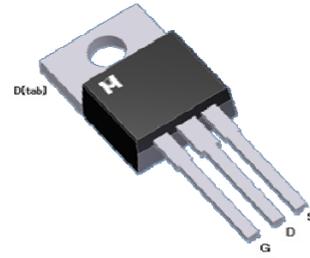
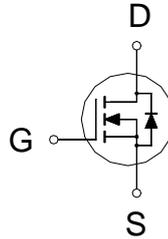


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

| | |
|---------------------|---------------|
| BV_{DSS} | 100V |
| $R_{DS(on)}$ (MAX.) | 7.5m Ω |
| I_D | 130A |



UIS, Rg 100% Tested

Pb-Free Lead Plating



ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^\circ\text{C}$ Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS | | SYMBOL | LIMITS | UNIT |
|--|--|------------------|------------|------------------|
| Gate-Source Voltage | | V_{GS} | ± 30 | V |
| Continuous Drain Current | $T_C = 25\text{ }^\circ\text{C}$ | I_D | 130 | A |
| | $T_C = 100\text{ }^\circ\text{C}$ | | 93 | |
| Pulsed Drain Current ¹ | | I_{DM} | 540 | |
| Avalanche Current | | I_{AS} | 90 | |
| Avalanche Energy | $L = 0.1\text{mH}, I_D=90\text{A}, R_G=25\Omega$ | E_{AS} | 405 | mJ |
| Repetitive Avalanche Energy ² | $L = 0.05\text{mH}$ | E_{AR} | 202 | |
| Power Dissipation | $T_C = 25\text{ }^\circ\text{C}$ | P_D | 227 | W |
| | $T_C = 100\text{ }^\circ\text{C}$ | | 90 | |
| Operating Junction & Storage Temperature Range | | T_{j}, T_{stg} | -55 to 150 | $^\circ\text{C}$ |

100% UIS testing in condition of $V_D=50\text{V}, L=0.1\text{mH}, V_G=10\text{V}, I_L=60\text{A}, \text{Rated } V_{DS}=100\text{V N-CH}$

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE | SYMBOL | TYPICAL | MAXIMUM | UNIT |
|---------------------|-----------------|---------|---------|-----------------------------|
| Junction-to-Case | $R_{\theta JC}$ | | 0.55 | $^\circ\text{C} / \text{W}$ |
| Junction-to-Ambient | $R_{\theta JA}$ | | 62.5 | |

¹Pulse width limited by maximum junction temperature.

²Duty cycle $\leq 1\%$



ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | LIMITS | | | UNIT |
|---|---------------|--|--------|------|-----------|------------|
| | | | MIN | TYP | MAX | |
| STATIC | | | | | | |
| Drain-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS} = 0V, I_D = 250\mu A$ | 100 | | | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 2 | 3 | 4 | |
| Gate-Body Leakage | I_{GSS} | $V_{DS} = 0V, V_{GS} = \pm 30V$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 80V, V_{GS} = 0V$ | | | 1 | μA |
| | | $V_{DS} = 70V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ | | | 25 | |
| On-State Drain Current ¹ | $I_{D(ON)}$ | $V_{DS} = 10V, V_{GS} = 10V$ | 130 | | | A |
| Drain-Source On-State Resistance ¹ | $R_{DS(ON)}$ | $V_{GS} = 10V, I_D = 35A$ | | 6.3 | 7.5 | m Ω |
| Forward Transconductance ¹ | g_{fs} | $V_{DS} = 25V, I_D = 35A$ | | 60 | | S |
| DYNAMIC | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0V, V_{DS} = 50V, f = 1\text{MHz}$ | | 5587 | | pF |
| Output Capacitance | C_{oss} | | | 428 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 23 | | |
| Gate Resistance | R_g | $V_{GS} = 15\text{mV}, V_{DS} = 0V, f = 1\text{MHz}$ | | 1.7 | | Ω |
| Total Gate Charge ^{1,2} | Q_g | $V_{DS} = 50V, V_{GS} = 10V, I_D = 20A$ | | 64 | | nC |
| Gate-Source Charge ^{1,2} | Q_{gs} | | | 34 | | |
| Gate-Drain Charge ^{1,2} | Q_{gd} | | | 11 | | |
| Turn-On Delay Time ^{1,2} | $t_{d(on)}$ | $V_{DS} = 50V, I_D = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$ | | 70 | | nS |
| Rise Time ^{1,2} | t_r | | | 150 | | |
| Turn-Off Delay Time ^{1,2} | $t_{d(off)}$ | | | 100 | | |
| Fall Time ^{1,2} | t_f | | | 170 | | |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ\text{C}$) | | | | | | |
| Continuous Current | I_S | | | | 130 | A |
| Pulsed Current ³ | I_{SM} | | | | 540 | |
| Forward Voltage ¹ | V_{SD} | $I_F = 20A, V_{GS} = 0V$ | | | 1.3 | V |
| Reverse Recovery Time | t_{rr} | $I_F = 20A, di_F/dt = 100A/\mu S$ | | 50 | | nS |
| Reverse Recovery Charge | Q_{rr} | | | | 170 | |

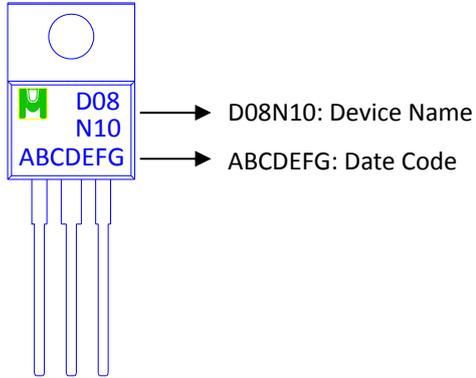
¹Pulse test : Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

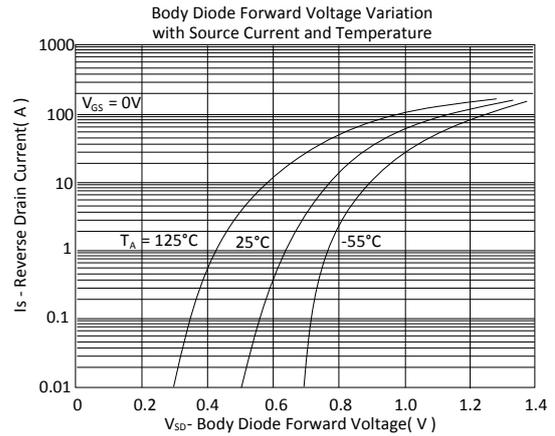
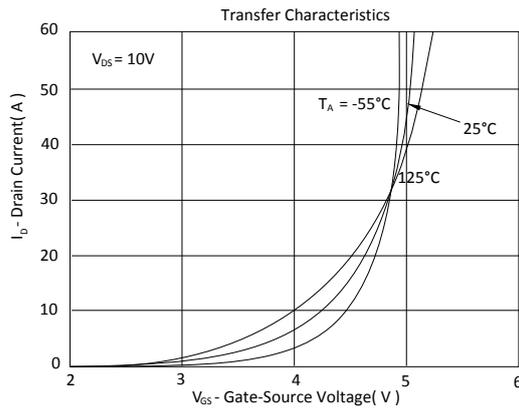
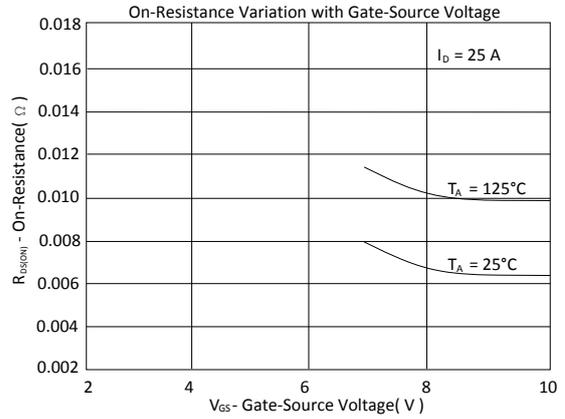
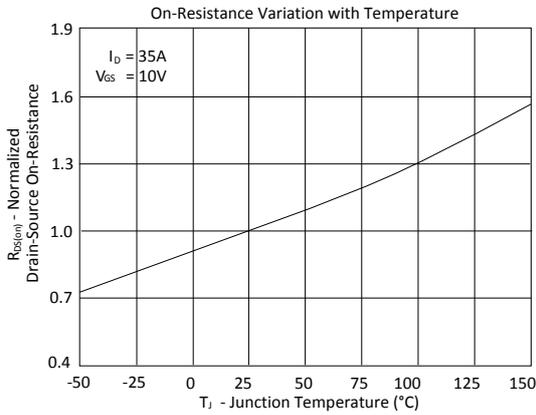
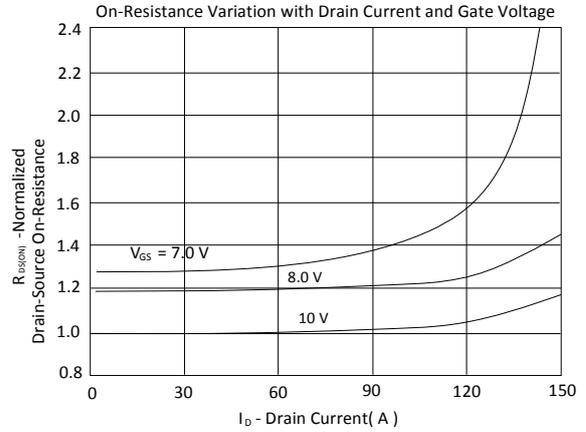
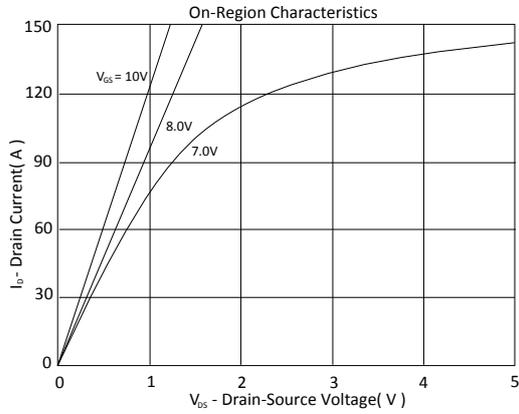
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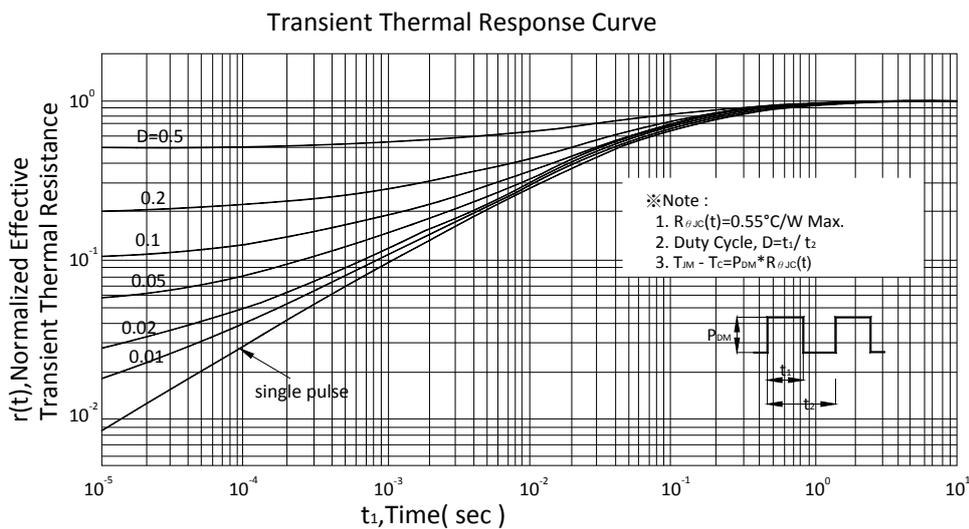
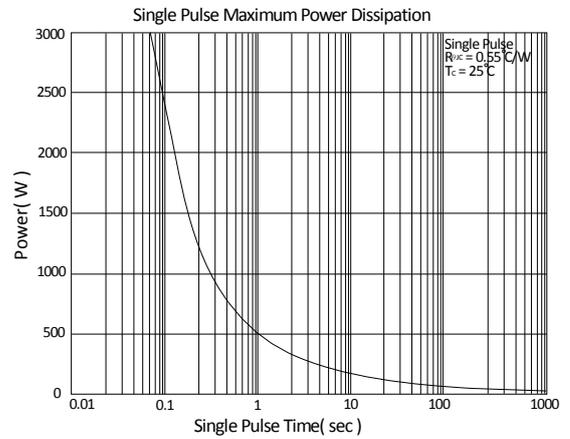
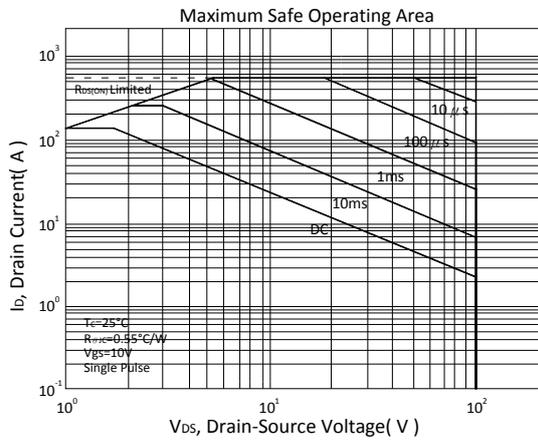
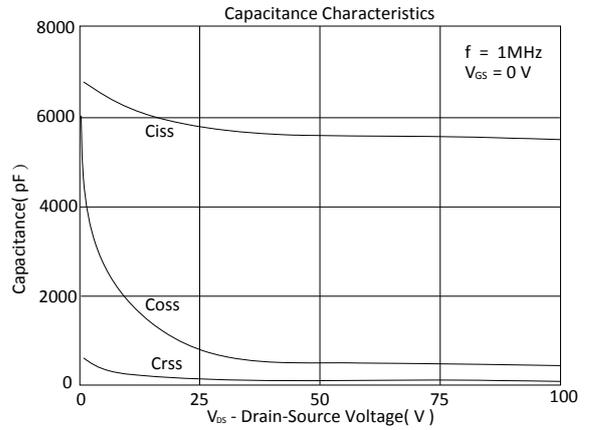
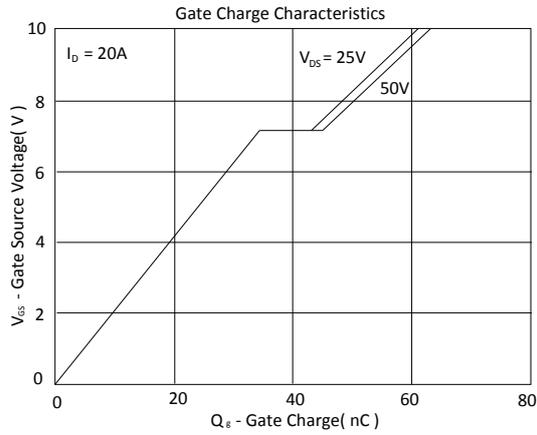
Device Name: EMD08N10E for TO-220





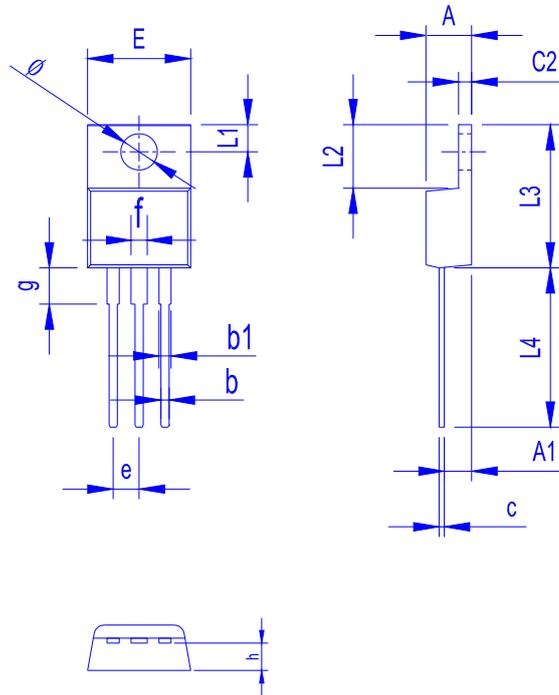
TYPICAL CHARACTERISTICS







Outline Drawing



Dimension in mm

| Dimension | A | b | b1 | c | c2 | E | L1 | L2 | L3 | L4 | ø | e | f | g | h |
|-----------|------|------|------|------|------|-------|------|------|-------|-------|------|------|------|------|------|
| Min. | 4.20 | 0.70 | 0.90 | 0.30 | 1.10 | 9.80 | 2.55 | 6.10 | 14.80 | 13.50 | 3.40 | 2.35 | 1.30 | 3.40 | 2.40 |
| Max. | 4.80 | 1.10 | 1.50 | 0.70 | 1.50 | 10.50 | 2.85 | 6.50 | 15.40 | 14.50 | 3.80 | 2.75 | 1.90 | 3.80 | 3.00 |